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Determination of vertical phase separation in a polyfluorene copolymer

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Supplementary Information

Figure 1. TM-AFM height (a) and phase (b) images of F8DTBT:PCBM, 10x10μm.
RMS roughness = 2.1 nm

Figure 2. TM-AFM height (a) and phase (b) images of F8DTBT:PCBM, 1x1μm. RMS roughness = 0.84 nm

Figure 3: X-ray photoemission spectrum of the $C1s$ core level region of the polyfluorene copolymer (F8DTBT) collected with 2010 eV. An inset was added to allow for better comparison with the spectrum of the F8DTBT:PCBM blend taken with the same energy.